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|-----------------------------------|--|---------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination FUKASAWA ET AL. | |
| | | Examiner Susan T. Tran | Art Unit 1615 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-3,660,304 | 05-1972 | Matsukawa et al. | 264/4.3 |
| * | B | US-4,349,454 | 09-1982 | Iwasaki et al. | 516/75 |
| * | C | US-5,456,985 | 10-1995 | Zgoulli et al. | 428/402.2 |
| * | D | US-5,700,397 | 12-1997 | Maeda et al. | 428/402.24 |
| * | E | US-7,067,153 | 06-2006 | Grisoni, Philippe | 424/490 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|----------|-----------------|----------------|
| * | N | EP 0077956 A1 | 04-1983 | European | Samejima et al. | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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